

Notice of References Cited	Application/Control No. 09/651,944	Applicant(s)/Patent Under Reexamination- DRAPKIN ET AL.	
	Examiner Hiep Nguyen	Art Unit 2816	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
	A	US-5,808,488	09-1998	Brucoleri et al.	327	57
	B	US-				
	C	US-				
	D	US-				
	E	US-				
	F	US-				
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	I	US-				
	J	US-				
	K	US-				
	L	US-				
	M	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N	JP02000252430A	09-2000	Japan	Ishikawa et al.	--	--
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	R						
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	T						

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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